





Room-temperature broad-band radiofrequency rectification in epitaxial SrIrO₃ films

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Although significant advancements have been made in wireless technologies and portable devices, it remains a challenge for high-frequency and nanowatt-level radiofrequency rectification. In this work, we report a pronounced radiofrequency rectification up to 37 GHz in nominally centrosymmetric SrIrO₃ epitaxial films, with the minimum detectable power as low as −15 dBm. Strikingly, the SrIrO₃ rectifier is highly field tunable and exhibits a strong in-plane field anisotropy, thus showing a unique advantage in broadband radiofrequency rectification. The rectification effect can persist up to at least 360 K and shows a sensitive temperature dependence including a sign inversion. By a systematic study of the nonlinear transport properties of SrIrO₃, it's further revealed that the radiofrequency rectification originates from the nonlinear Hall effect with the dominant contribution from field-induced Berry curvature dipole. Our work demonstrates the superior performance of the field-tunable SrIrO₃ rectifiers, unleashing the great application potential of centrosymmetric materials in harvesting and detecting ambient electromagnetic energy.

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Introduction. Wireless radiofrequency (RF) rectification boosts flexibility and efficiency of energy transmission, greatly enhancing the integration of distributed electronic technology into industries and daily lives. With the rapid development of micro and nanoelectronics, high-frequency rectifiers are in high demand, particularly those operating in the microwatt and nanowatt range. Nevertheless, due to the limited electron transition time, the diode-based rectifiers exhibit poor RF performance at high frequencies (> GHz). At present, it is still challenging to achieve RF rectification with the frequency above 100 GHz. In view of this, the recent discovery of high-frequency rectification based on the nonlinear Hall effect (NLHE) has been attracting extensive attention [1,2]. The NLHE, which generates a second-order Hall response to an alternating current in the absence of an external magnetic field, features two components, i.e., a zero-frequency rectification component and a double-frequency component [3–9]. This rectification based on the NLHE emerges as a promising solution for high-frequency rectifiers, overcoming the inherent frequency limitations of semiconductor diodes [1,6]. However, earlier works about the NLHE appear predominantly at low temperatures and in noncentrosymmetric materials, such as bilayer or few-layer

WTe₂ [10,11], MoTe₂ [12], graphene [13,14], WSe₂ [15,16], Bi₂Se₃ [17], and ZrTe₅ [18], which greatly limits its application scenarios. Recently, a few studies have demonstrated the room-temperature RF rectification in noncentrosymmetric TaIrTe₄ [19], BiTeBr [20], Te [21,22], and BaMnSb₂ [23]. However, the first two are exfoliated mechanically from crystals and the last two are nanoflakes or bulk crystals, which would hinder integration into large-scale applications. Encouragingly, applying an external DC electric field could induce a NLHE in centrosymmetric materials like bulk WTe₂ [24,25], but an efficient room-temperature RF rectification is still absent in the literature.

In this work, we demonstrate successfully a field-induced RF rectification up to at least 37 GHz at room temperature in centrosymmetric SrIrO₃ epitaxial films. In particular, the rectifier exhibits high magnitude and sign tunability to the DC electric field, with the resultant rectified voltage about one order of magnitude larger than previously reported values in diode-free rectifiers [20]. By in-plane field rotation, we further reveal a strong field anisotropy of this RF rectification. It's found that the rectified response is greatly enhanced once the field direction is parallel with the mirror lines of SrIrO₃. Due to a temperature-driven shift in the Fermi energy, a sensitive temperature dependence is also observed for the rectification, featuring a sign inversion at about 220 K. A comparative study of this RF rectification and the NLHE leads us to believe that the rectification arises from the NLHE with dominant intrinsic contribution from field-induced Berry curvature dipole. Our

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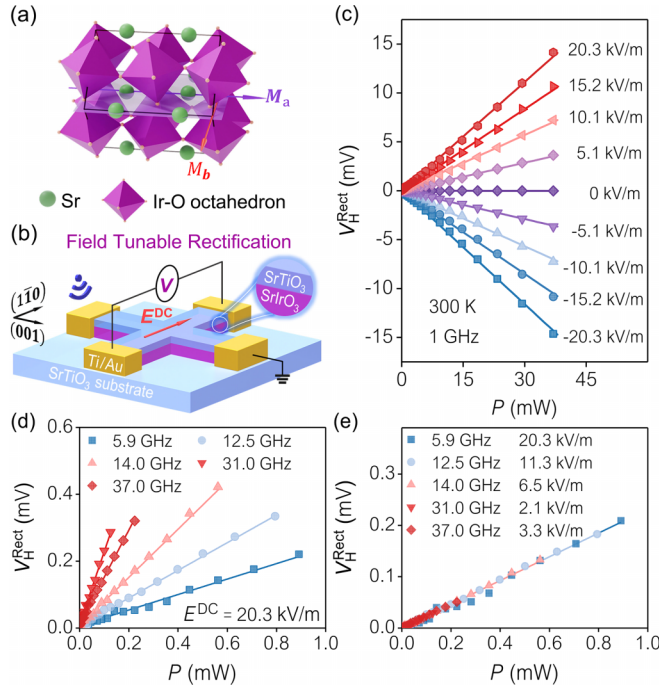


FIG. 1. (a) Schematic crystal structure of SrIrO_3 , with the arrows indicating the two mirror lines M_a and M_b . (b) Measurement setup for the RF rectification voltage V_H^{Rect} induced by a DC electric field E^{DC} . (c) With the frequency fixed at 1 GHz, the $V_H^{\text{Rect}}(P)$ curves measured under different E^{DC} conditions. (d) With $E^{\text{DC}} = 20.3$ kV/m, the $V_H^{\text{Rect}}(P)$ curves measured under different RF conditions. (e) The $V_H^{\text{Rect}}(P)$ curves for different frequencies overlap each other by setting appropriate E^{DC} .

work not only shows the efficient field-tunable rectification of ambient RF signals in SrIrO_3 epitaxial films, with a unique advantage for future large-scale broad-band applications, but also paves the way for other centrosymmetric materials to be utilized in RF rectifiers or detectors.

Results and discussions. The $5d$ transition metal oxide SrIrO_3 , belonging to the centrosymmetric $Pbnm$ space group, has been shown to exhibit a nonlinear planar Hall effect within an in-plane magnetic field [26–30], but no rectification or NLHE has been addressed. Our SrIrO_3 film was epitaxially grown on the SrTiO_3 (001) substrate (Fig. S1 [31]). It is worth pointing out that there exist a mirror symmetry plane and a glide mirror symmetry plane in the epitaxial SrIrO_3 film, which are perpendicular to the $(1\bar{1}0)$ and (001) crystal directions, respectively [32–34], as indicated in Fig. 1(a). Figures 1(b) & S2 [31] show schematically the device structure and circuit diagram to investigate the RF rectification in SrIrO_3 . The device is exposed to RF radiation (e.g., at 1 GHz) with the DC electric field E^{DC} applied along the direction $(1\bar{1}0)$ and the rectification voltage V_H^{Rect} measured in the same direction. Note that in obtaining V_H^{Rect} , the background DC voltage due to E^{DC} has been subtracted (Fig. S3) [31].

As shown in Figs. 1(c) and S6 [31], in the absence of an external DC electric field E^{DC} , the RF rectification effect at 300 K is negligible, i.e., $V_H^{\text{Rect}} \sim 0$, regardless of the input RF power (P). However, upon applying E^{DC} , a pronounced RF rectification response is observed, with the rectification

voltage V_H^{Rect} linearly dependent on the input RF power. The rectification voltage V_H^{Rect} can be effectively modulated by the applied E^{DC} , i.e., the magnitude of V_H^{Rect} increases as stronger electric fields are applied and the sign changes once the field direction is reversed. Additionally, as shown in Fig. 1(d), the RF rectification effect can occur up to 37 GHz, which not only surpasses the traditional silicon diode cut-off frequency [42], but also shows potential applications in Wi-Fi (2.4 GHz, 5.9 GHz), UAV communications (1–40 GHz), radar systems (1–12 GHz), and satellite communications (12–40 GHz). Remarkably, the voltage responsivity R_V defined as the slope of the $V_H^{\text{Rect}}(P)$ curve can reach up to at least 0.22 V/W at 5.9 GHz, one order of magnitude larger than the largest value reported so far in rectifiers based on the intrinsic NLHE (~ 0.02 V/W at 5.9 GHz in BiTeBr [20], see Table S1 and Fig. S5(a) [31]). Moreover, the RF rectification of SrIrO_3 can be observed with the RF power down to -15 dBm, as shown in Fig. S5(b) [31]. This power threshold falls within the ambient RF power range between -20 and -10 dBm [42], indicating the rectifier’s capability to rectify the ambient RF signals. Most importantly, due to the field-tunability shown in Fig. 1(c), or the linear field dependence of R_V shown in Fig. S7 [31], the SrIrO_3 rectifier can even be electrically tuned to have the same R_V when subjected to RF excitations with different frequencies. As shown in Fig. 1(e), by setting appropriate E^{DC} , the obtained $V_H^{\text{Rect}}(P)$ curves coincide with each other, yielding the same value of R_V . Note that for a comparison between the results shown in Figs. 1(d) and 1(e), the electric field condition is kept the same for 5.9 GHz. This field-tunability thus gives the SrIrO_3 rectifier a unique advantage over other rectifiers in broad-band RF rectifications [31,43]. All the above results collectively demonstrate the superior performance of RF rectification in SrIrO_3 (Supplemental Material, Secs. S4 and S5 [31]), suggesting the great application potential in harvesting and detecting broad-band and high-frequency ambient electromagnetic energy.

We have further investigated the field anisotropy of the RF rectification effect. To do so, we have prepared a disk-shaped multiterminal device as illustrated in Fig. 2(a). An alternating electric field E^ω at 1 GHz is applied in the (001) direction. We measure the rectification voltage V_H^{Rect} in the $(1\bar{1}0)$ direction while varying the direction of E^{DC} . Here, the angle between E^{DC} and (001) is denoted as θ and the magnitude of E^{DC} is fixed at 20.3 kV/m. Figure 2(b) shows that the field-induced RF rectification is negligible when the DC field is along the (001) direction ($\theta = 0^\circ$ and 180°), the same as the applied alternating electrical field E^ω . As the DC field is tilted away from the (001) direction, the V_H^{Rect} is enhanced. The rectification effect is maximized when the field is perpendicular to the (001) direction, i.e., $\theta = 90^\circ$ and 270° . This angular dependence is very different from the background DC voltage due to E^{DC} (Fig. S4 [31]). We also swap the directions of E^ω and V_H^{Rect} , i.e., $E^\omega \parallel (1\bar{1}0)$ and $V_H^{\text{Rect}} \parallel (001)$, and repeat the above measurement. As shown in Fig. 2(c), the V_H^{Rect} is minimized at $E^{\text{DC}} \parallel (1\bar{1}0)$ ($\theta = 90^\circ$ and 270°), but maximized at $E^{\text{DC}} \parallel (001)$ ($\theta = 0^\circ$ and 180°), opposite to the results in Fig. 2(b). To see more clearly the field direction dependence of the RF rectification, we plot the values of R_V as a function of the field angle θ for both $E^\omega \parallel (001)$ or $E^\omega \parallel$

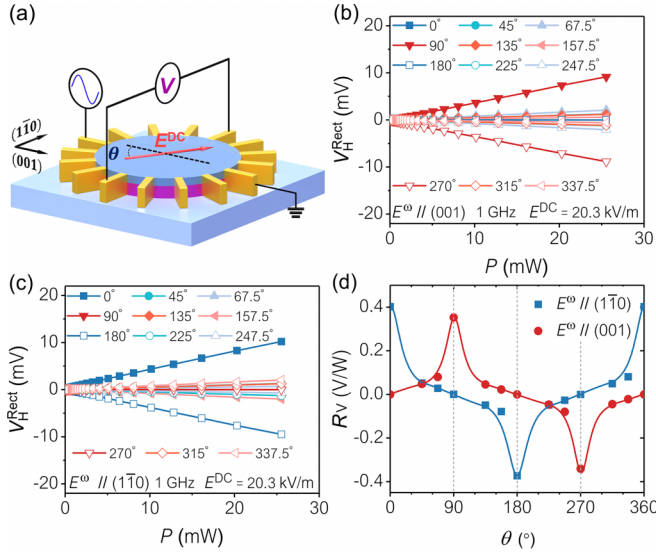


FIG. 2. (a) Device layout and measurement configuration for studying the rectification anisotropy. The angle between the DC electric field E^{DC} and the (001) crystal direction is denoted as θ . The magnitude of E^{DC} and radiation frequency are fixed at 20.3 kV/m and 1 GHz, respectively. (b) With $E^{\omega} \parallel (001)$ and $V_H^{\text{Rect}} \parallel (1\bar{1}0)$, the measured $V_H^{\text{Rect}}(P)$ curves under different θ conditions. (c) With $E^{\omega} \parallel (1\bar{1}0)$ and $V_H^{\text{Rect}} \parallel (001)$, the measured $V_H^{\text{Rect}}(P)$ curves under different θ conditions. (d) Derived rectification voltage responsivity R_V for different DC electric field directions with $E^{\omega} \parallel (1\bar{1}0)$ and (001), respectively. The solid lines in Fig. 2(d) are guide for the eye.

(110)] in Fig. 2(d). A strong field anisotropy of the rectification effect is clearly observed, possibly due to the combined effect of fundamental symmetry constraints and resistivity anisotropy on this phenomenon (Supplemental Material, Sec. S6 [31]).

Besides the anisotropy of this rectification, we have also studied the influence of temperature on the field-induced RF rectification effect in SrIrO₃. Figure 3(a) shows the $V_H^{\text{Rect}}(P)$ curves at different temperatures, with $E^{\omega} \parallel (001)$ and $E^{\text{DC}} \parallel (1\bar{1}0)$ to maximize the rectification effect. The rectification voltage V_H^{Rect} remains linearly dependent on the input power P at any measured temperature. But the slope of the

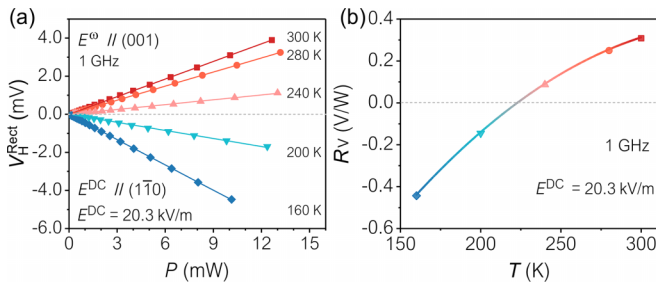


FIG. 3. (a) The $V_H^{\text{Rect}}(P)$ curves measured at different temperatures. To maximize the rectification effect, the E^{ω} at 1 GHz is applied in the (001) direction, while with $E^{\text{DC}} = 20.3$ kV/m in the (110) direction. (b) The derived rectification voltage responsivity R_V as a function of temperature.

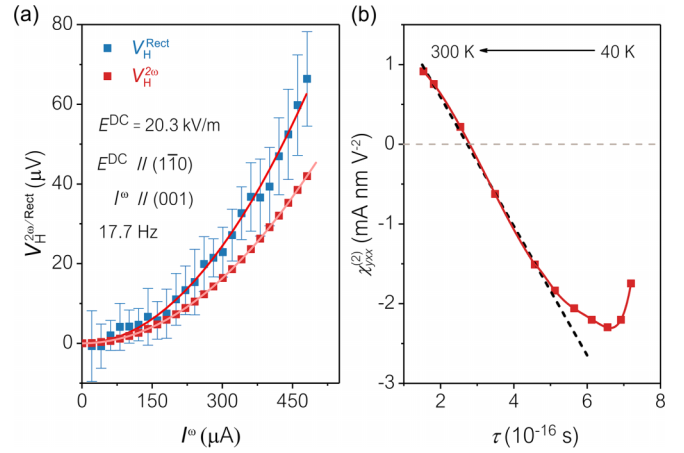


FIG. 4. (a) The AC current I^{ω} dependence of the field-induced rectification and second-harmonic Hall voltages V_H^{Rect} and $V_H^{2\omega}$ at $T = 300$ K. The AC current with the frequency of 17.7 Hz and the DC electric field $E^{\text{DC}} = 20.3$ kV/m are applied in the (001) and (110) directions, respectively. Both curves can be well fitted with $V_H = \alpha(I^{\omega})^2$. (b) The scattering time τ dependence of the nonlinear second-order conductivity $\chi_{xy}^{(2)}$.

$V_H^{\text{Rect}}(P)$ curve varies with changing temperature. Especially there exists a temperature-induced sign change in the slope. Figure 3(b) shows the temperature dependence of the rectification voltage responsivity R_V , obtained by linear fitting of the curves in Fig. 3(a). The R_V exhibits a monotonically increasing behavior as the temperature increases. Around 220 K, a sign inversion from negative to positive is observed. Note that similar phenomena have also been observed in other SrIrO₃ rectifiers (Fig. S11 [31]). The RF rectification can persist up to at least 360 K [19–23]. These results clearly show the sensitive temperature dependence of the RF rectification in SrIrO₃. Moreover, a 75% enhancement in the rectification efficiency from 300 K to 360 K suggests the great potential for high-temperature applications of SrIrO₃ rectifiers (Supplemental Material, Sec. S7 [31]).

The linear dependence of rectification voltage on the input power, as well as its strong anisotropy, align well with the NLHE [1,24]. Though the NLHE generally occurs in noncentrosymmetric systems, previous research has shown that applying an external DC electric field can also induce a NLHE in centrosymmetric materials due to nonzero Berry connection polarizability, such as bulk WTe₂ [24]. To investigate whether the observed RF rectification originates from the NLHE, we have measured the two components of NLHE simultaneously, i.e., the rectified and second-harmonic Hall voltages V_H^{Rect} and $V_H^{2\omega}$, at a frequency of 17.7 Hz. The results are shown in Fig. 4(a) where the alternating current I^{ω} was applied in the (001) direction and the DC electric field $E^{\text{DC}} = 20.3$ kV/m in the (110) direction. Both the measured V_H^{Rect} and $V_H^{2\omega}$ show a quadratic dependence on I^{ω} , as indicated by the red fitting curves with $V_H = \alpha(I^{\omega})^2$. It is also found that $V_H^{\text{Rect}} \sim 1.44V_H^{2\omega}$, in agreement with a previous experimental study of the NLHE in BaMnSb₂ [23]. Considering that the $V_H^{2\omega}$ measured by a lock-in amplifier is its root-mean-square value, the above finding indicates that the amplitude of $V_H^{2\omega}$ is almost equal to V_H^{Rect} , consistent with the theoretical

expectations [3]. Like the RF rectification, the DC electric field is also crucial to the observation of second harmonic Hall voltage. $V_H^{2\omega} \sim 0$ if no DC electric field E^{DC} is applied (Fig. S12(a) [31]). This is expected as there is no inversion symmetry breaking in our SrIrO₃ films. But in the presence of a DC electric field, we can detect an obvious $V_H^{2\omega}$. All the measured $V_H^{2\omega}$ shows a quadratic dependence on I^ω (Fig. S12(a) [31]). We have also studied the field anisotropy of the $V_H^{2\omega}$ (Fig. S12 [31]) and its reciprocity by interchanging the I^ω and $V_H^{2\omega}$ terminals (Fig. S13 [31]), which are consistent with the results of the RF rectification shown in Fig. 2. Therefore, the simultaneous observation of the quadratic V_H^{Rect} and $V_H^{2\omega}$ with equal magnitudes and the consistent field anisotropy of the nonlinear response strongly indicate that the RF rectification is intimately linked to the NLHE in SrIrO₃.

Generally, the NLHE obeys the scaling law $\chi_{yxx}^{(2)} = (L^3/W^2 d R_L^3)[V_H^{2\omega}/(I^\omega)^2] = \eta_1 \tau + \eta_2 \tau^2 + \eta_3 \tau^3$, where $L(W)$ is the effective length (width) of the device, d is the thickness of the sample, τ is the scattering time, and the parameter η_i characterizes the different contributions to the second-order nonlinear Hall conductivity $\chi_{yxx}^{(2)}$ [25,44,45]. The η_1 term scaling as τ might originate from the Berry curvature dipole or extrinsic scattering [4,11,17,44,46]. The extrinsic scattering, including the side jump and skew scattering, give rise to the η_2 term which scales as τ^2 [44]. The last term is usually ascribed to the Drude transport or skew scattering [19,44]. Therefore, based on the nonlinear Hall data and scattering time τ obtained at different temperatures, one can perform the scaling law analysis to evaluate the different contributions to the NLHE. Such analysis has been done in previous studies of the NLHE in T_d-MoTe₂ [12], bilayer graphene [13], Ce₃Bi₄Pd₃ [47], BaMnSb₂ [23], MnBi₂Te₄ [45], etc., as well as the field-induced NLHE in WTe₂ [24,25].

We have also analyzed the dependence of the second-order conductivity $\chi_{yxx}^{(2)}$ on the scattering time τ , as shown in Fig. 4(b). The $\chi_{yxx}^{(2)}$ is obtained using the formula $\chi_{yxx}^{(2)} = (L^3/W^2 d R_L^3)[V_H^{2\omega}/(I^\omega)^2]$ and τ is derived with the formula $\tau = m^* \sigma / ne^2$, where m^* is the effective mass [39], n is the carrier concentration, and σ is the electrical conductivity. Based on the ordinary Hall measurement, the derived values of τ and n at different temperatures are shown in Fig. S14 [31]. As seen in Fig. 4(b), the $\chi_{yxx}^{(2)}$ initially shows a linear dependence on τ , as indicated by the black dashed line. Note that there also occurs a sign change in $\chi_{yxx}^{(2)}$. As the scattering time increases, $\chi_{yxx}^{(2)}$ gradually deviates from this linear trend, and shows an upturn at high τ values. As for the sign inversion in $\chi_{yxx}^{(2)}$, we recall that similar phenomena have been observed in TaIrTe₄ and ascribed to the change in the intrinsic contribution due to a temperature-induced shift in the Fermi level [19]. Since the carrier density in Fig. S14 [31] shows an obvious decrease with decreasing temperatures, i.e., the Fermi level shifts down as temperatures decrease, we thus believe that the same mechanism is also applicable to SrIrO₃. The linear scattering time dependence of $\chi_{yxx}^{(2)}$, as well as this temperature-induced sign inversion, leads us to ascribe the field-induced NLHE to the BCD, rather than extrinsic scattering [19,24,48,49]. It's worth pointing out that almost at the same temperature, the rectification voltage responsivity R_V also exhibits a sign change, as shown in Fig. 3(b). Therefore,

the observation of sign changes in $\chi_{yxx}^{(2)}$ and R_V once again points to the close connection between the NLHE and the RF rectification. To understand the deviation of $\chi_{yxx}^{(2)}$ from the linear behavior at high τ values, we notice that the minimum of $\chi_{yxx}^{(2)}$ occurs at about 110 K by comparing Fig. 4(b) and S14 [31]. As revealed in previous studies [50], the SrTiO₃ substrate endures a cubic-to-tetragonal phase transition around 110 K. This coincidence thus suggests that the structural phase transition in the SrTiO₃ substrate could influence the NLHE of the SrIrO₃ films epitaxially grown on the substrate [18]. Compared with $\chi_{yxx}^{(2)}$, other transport parameters, such as n and τ in Fig. S14 [31], show no obvious change around 110 K. Therefore, the NLHE is far more sensitive to the crystal symmetry, which might be important to the crystal symmetry characterization in various materials [6]. Moreover, beyond the common assumption $E^\omega \ll E^{\text{DC}}$, our results (Supplemental Material, Sec. S8.4 [31]) show no discernible effect of the perturbation of BCD by E^ω on the measured V_H^{Rect} and $V_H^{2\omega}$, even at $E^\omega \sim E^{\text{DC}}$.

Note that the observed NLHE is not due to the diode rectification effect as Ohmic contacts to the SrIrO₃ film with linear voltage-current characteristics obtained in our experiment. The anisotropy of the NLHE also suggests the minor role of thermal or thermoelectric effects in generating the phenomena (Supplemental Material, Sec. S9 [31]). But for a full understanding of the above-discussed nonlinear transport phenomena in SrIrO₃, a first-principle calculation of Berry curvatures and its comparison with the experimental results are highly desired in the near future.

Conclusions. Field-tunable RF rectification up to 37 GHz has been successfully realized in centrosymmetric epitaxial SrIrO₃ thin films at temperatures as high as 360 K and ascribed to the field-induced NLHE. The rectifier exhibits superior rectification performance and shows a unique advantage in broadband applications due to the field tunability. Therefore, our work would shed new light on the utilization of centrosymmetric materials in harvesting and detecting ambient electromagnetic energy. Different from previous studies where room-temperature RF rectifications were reported in micrometer-sized flakes mechanically exfoliated from bulk crystals or fabricated by focused ion beam [19–23], the SrIrO₃ films studied in this work are epitaxially grown on centimeter-sized substrates, which is thus of particular importance in large-scale fabrication and integration. Besides, the perovskite oxide family has been known to host a broad spectrum of functional properties, such as the ferroelectricity, piezoelectricity, pyroelectricity, and magnetism [51]. The epitaxial integration of SrIrO₃ thin films with other perovskite oxides, together with the efficient field-tunable RF rectification observed in this work, might offer abundant possibilities for future multifunctional device designs.

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